

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/727,799	GETTMAN ET AL.	
Examiner	Art Unit	
Le Nguyen	2174	

SEARCHED					
Class	Subclass	Date	Examiner		
715	757	3/27/2007	LVN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examine	
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	ib, USPAT: 5/757	4/27/2007	LVN	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
inventor name search	4/26/2007	LVN			
US-PGPub, USPAT: 715/751- 759,838, 712,853-855	3/27/2007	lvn			